## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10614744	HICKS ET AL.
Examiner	Art Unit
CHITCK HITANIA	2617

SEARCHED			
Class	Subclass	Date	Examiner
Updated		6/18/2009	/CH/
Search			
455	466, 432.3, 435.1, 433	6/18/2009	/CH/

SEARCH NOTES			
Search Notes	Date	Examiner	
Class/Subclass	6/18/2009	/CH/	
Inventor/Assignee	6/18/2009	/CH/	
Review Previous Art	6/18/2009	/CH/	
Talked to Primary Ajit Patel and allowance was agreed upon	6/18/2009	/CH/	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	329	6/18/2009	/CH/

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